Highlights: Expert Forum for Producers and Users of Disaster-related Statistics

June 8, 9 and 10, 2021
What went well:

- Brought together different groups of communities (WHO, GEO,) and experts
- Wealth of experts and experiences abound
- GIS component on disaster-related statistics brought new dimension to the community
- Sharing of best practices, country experiences, and challenges
- Enabled countries to know the status on the production of disaster-related statistics world-wide and their countries’ standing with respect to the rest of the world
- Normative work done by the regional commissions serve as starting point for actual/practical implementation of disaster-related statistics in countries
Potential Areas of Research for the Inter-Agency and Expert group (IAEG)

- Economic loss from disaster
- Valuation methodology of issues related to land use planning, building regulations and vulnerable populations from impacts/effects of disasters.
- Risk informed planning, in the context of the post 2020 and beyond 2030
- Linkage of health and climate change to disaster-related statistics
- Incorporate techniques and mechanisms used in NSOs for disaster risk estimation in NDMOs
- Inclusion of a governance model of geospatial information management in all phases of DRM in the common statistical framework
- Building capacity of member states on disaster-related statistics
Next Steps

- Preparation of Reports (standard and scientific) on the Expert Forum
- Next Expert Forum in 2022 to be hosted by UN Economic and Social Commission for West Asia (ESCWA); organizing committee: Core Group of the IAEG
- Next Expert Forum topics: health and climate change; implementation of disaster related statistics in countries; progress on the issues discussed in the first meeting
- Need for capacity training among countries before the next forum
- Clear deliverables for research topics for the IAEG
- Health, climate change and geospatial information figure prominently in the development of the common framework
Link to the Expert Forum documents and materials:


THANK YOU!